

Search Notes

Application/Control No.

10/707,177

Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

MASENAS, CHARLES J.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	101,113	5/19/2005	HLN
↓	114,172	↓	↓
↓	291	↓	↓
331	16,34,36R	↓	↓
↓	36C,177R	↓	↓
↓	36L,177V	↓	↓
↓	117FE,167	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Search	Above	5/22/2005	HLN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search	5/20/2005	HLN
EAST Text Search	5/20/2005	HLN